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DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

1. SCOPE					-
1.1 Scope. This drawing describes device with 1.2.1 of MIL-STD-883, "Provisions for non-JAN devices".	ce require the use o	ements f f MIL-S	or class B m TD-883 in co	icrocircuit njunction v	ts in accordance with compliant
1.2 Part number. The complete part num	ber shall	be as s	hown in the	following (	example:
5962-88505 01		<u>R</u>		<u>X</u>   	
Drawing number Device t (1.2.1	J F -	se out		finish per -M-38510	
1.2.1 Device types. The device types s	hall ident	tify the	circuit fun	ction as f	ollows:
Device type Generic number	•		rcuit functi	_	
01 AD573 02 AD673	10-b1 8-b11	it A/D o	onverter w/ onverter w/ m	microproce icroproces	ssor interface sor interface
1.2.2 <u>Case outline</u> . The case outline s as follows:	hall be a	s desig	nated in appe	endix C of	MIL-M-38510, and
Outline letter		-	case outline		
R D	-8 (20 le	ad, 1.0	50" X .310" X	( .200"), d	ual-in-line package
1.3 Absolute maximum ratings.					
VCC to digital common VEE to digital common Analog common to digital common	nte)			V dc lc dc VCC VCC to +150°C	, appendix C
1.4 Recommended operating conditions.					
VCC	(T <sub>A</sub> )		+5 V c 15 V 55°C		
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## 2. APPLICABLE DOCUMENTS

2.1 Government specification and standard. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

**SPECIFICATION** 

**MILITARY** 

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

### 3. REQUIREMENTS

- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
  - 3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.
  - 3.2.2 Case outline. The case outline shall be in accordance with 1.2.2 herein.
- 3.3 Electrical performance characteristics. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full ambient operating temperature range.
- 3.4 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.

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	IABL	I. Electrical p	eriormance cha	Tac ter 13th	·····		——-т	
Test !	Symbol	Conditi -55°C < T <sub>A</sub> < +	ons 1/ 125°C		Group A    subgroups	Limi	ts	Unit
	, 1 , 1	unless otherwi	se specified	1		Min	Max	
Relative accuracy	RA i	Unipolar and b	ipolar major	A11	1	195	+.195	% of
		transactions ±	3 codes	01	2,3,12	098	+.098	FS
	1			02	2,3	195	+.195	
Differential	IDNR	All codes test		01	1	8	!	   Bits
nonlinearity	· .	unipolar and b 2/	oipolar	01	2,3,12	10		
		_		02	1,2,3	8		
Full-scale error	Ae	Unipolar <u>3</u> /		All	1	  -40 	+40 	mV
	- -	Bipolar <u>3</u> /		All	1	-20 	+20	Γ   
Full-scale	   Δ <b>Ae</b>			01	2,3	488	+.488	
temperature drift	Δt	<u> </u>		02	2,3	781	.781	FS
Offset error	I V <sub>OS</sub>	First transit	ion	A11	1	  -20	  +20	l L mV
011300 0110.	103	1		01	12	-10	10	<u> </u>
Offset temperature	  ΔV <sub>OS</sub> /			01	2,3	  195	  +.195	
drift	Δt	<u> </u> 		02	2,3	  391	+.391	FS
Bipolar zero error	Boze	Low side MSB t	ransaction	A11	1	  -20_	  +20	l mV
5.poid. 2010 01101	-   -   -   -   -   -   -   -   -   -	bipolar				-10	+10	
Bipolar zero	I IABPZE/	Low side MSB t	ransaction	01	2,3	195	+.195	1 % of
temperature drift	Δt	bipolar		02	2,3	391	+.391	T FS
Tri-state leakage	IOLT	VOH = 5.0 V	   DBO - DB9	01	1,2,3	  -40	  +40	ļ μA
current	-UL1	V <sub>OH</sub> = 5.0 V V <sub>OL</sub> = 0.0 V	DBO - DB9	02	1,2,3	T  -40	  +40	1

See footnotes at end of table.

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Test	Symbol	Condi	tions 1/ +125°C wise specified	Device types	Group A  subgroups 	Limi Min		Unit
Power supply rejection ratio	PSRR	V <sub>CC</sub> = 5.0 V, -1  14.25 V		All	1,2,3	-78.1	+78.1	mV
	 		12.6 V <u>&lt;</u> V <sub>EE</sub> <u>&lt;</u>	01	12	-19.5	+19.5	
Power supply current	Icc	DATA READY low or DATA READY (during conve	high rsion), T <sub>A</sub> = 25°C	A11	1		15	mA
	IEE	T <sub>A</sub> = 25°C		All	   1 	-15	!   	ļ 
Input voltage (high)	V <sub>IH</sub>		4/	A11 	1,2,3	2.0	!   	   V 
Input voltage (low)	VIL	_ <u>i</u>		All	1,2,3		0.8	     
Input current (high)	IIIH		4/	A11	1,2,3	-100	+100	μΑ
Input current (low)	IIL		4/	A11	1,2,3	-100	+100	     
Output voltage (low)	VOL	DATA READY, I I <sub>OL</sub> = +3.2 m/	DBO - DB9,	01	1,2,3		0.4	V
	 	DATA READY, I	DBO - DB7,	02	1,2,3	     	0.4	 
Output yoltage	Ì¥0H	DBO - DB9, I DBO - DB7, I	OH = -0.5 mA	01	1,2,3	2.4		1
(high)	311	DBO - DB7, I	OH = -0.5 mA	02	1,2,3	2.4	<del> </del>	<del> </del>
Input resistance	RIN			A11	4,5,6	3	7	KΩ
Conversion time	tc	See figure 2   TA = +25°C		A11	9	10	30	μS
Convert pulse width	tcs	<del>-                                    </del>		All	9	500		ns
See footnotes at e	nd of tab	ole.			<del></del>			
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T	ABLE I.	Electrical performance character	istics - (	Continued.			
Test	Symbol	Conditions $\frac{1}{C}$ $-55^{\circ}C \leq T_{A} \leq +125^{\circ}C$	Device   types	Group A subgroups	Limi	ts	Unit
	i I i	unless otherwise specified	1		Min	Max	
DATA READY delay convert	tosc	See figure 2   T <sub>A</sub> = +25°C	All	9		1.5	μS
Data valid after HBE or LBE high	t <sub>HD</sub>		01	9	50		l ns
Data valid after DATA ENABLE high			02		50   50		
Output float delay	t <sub>HL</sub>	See figure 2   T <sub>A</sub> = +25°C	A11	9		200	1      -
Data access time	t <sub>DD</sub>	T "   	A11	9		250	<u> </u>

- $V_{CC}$  = +5 V,  $V_{EE}$  = -15 V, analog input through  $15\Omega$  resistor to pin 13, unipolar configuration. Unipolar configuration pin 16 (bipolar offset control) is grounded. Bipolar configuration pin 16 is not connected.
- 2/ Minimum resolution for which no missing codes are guaranteed: For 01 (10-Bit resolution device), 0.098% of full scale = 1 LSB. For 02 (8-Bit resolution device), 0.391% of full scale = 1 LSB.
- 3/ Device 01 full scale error guaranteed trimmable with a  $200\Omega$  potentiometer. Device 02 full scale error guaranteed trimmable with a  $50\Omega$  potentiometer.
- 4/ Conditions for device 01 are CONVERT, LBE, and HBE. Conditions for device 02 are CONVERT and DATA ENABLE.
- 5/ Guaranteed, if not tested.
- 3.5 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements therein.
- 3.6 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.8 <u>Verification and review</u>. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

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# U. S. GOVERNMENT PRINTING OFFICE: 1968—549-904

	   Terminal	symbol f
  Device 	01	02
Case	l R	l R
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<sup>\*</sup> Pins 1 and 2 are internally connected to test points and should be left floating.

FIGURE 1. Terminal connections.

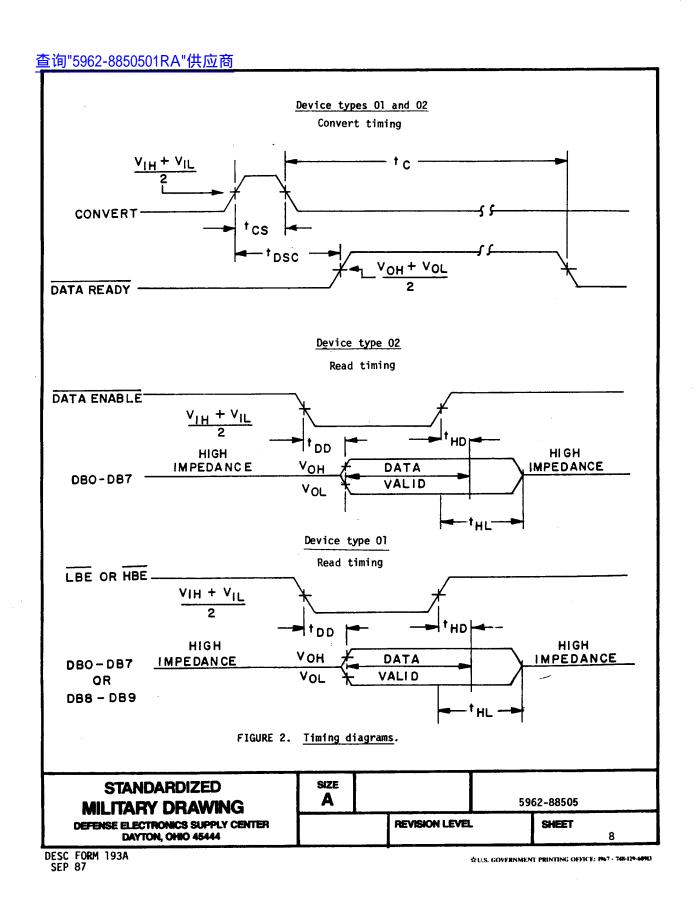
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- 4. QUALITY ASSURANCE PROVISIONS
- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 <u>Screening</u>. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
  - a. Burn-in test, method 1015 of MIL-STD-883.
    - (1) Test condition B using the circuit submitted with the certificate of compliance (see 3.5 herein).
    - (2)  $T_A = +125$ °C, minimum.
  - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
  - c. Optional subgroup 12 is used for grading and part selection at 25°C, and is not included in PDA.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
  - 4.3.1 Group A inspection.
    - a. Tests shall be as specified in table II herein.
    - b. Subgroups 7, 8, 10, and 11 in table I, method 5005 of MIL-STD-883 shall be omitted.
    - c. Optional subgroup 12 is used for grading and part selection at 25°C.
  - 4.3.2 Groups C and D inspections.
    - a. End-point electrical parameters shall be as specified in table II herein.
    - b. Steady-state life test conditions; method 1005 of MIL-STD-883:
      - (1) Test condition B using the circuit submitted with the certificate of compliance (see 3.5 herein).
      - (2)  $T_A = +125^{\circ}C$ , minimum.
      - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

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	TABLE	II.	Electrical	test	requirements.
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<u> </u>	·
MIL-STD-883 test requirements 	Subgroups (per method   5005, table I)
  Interim electrical parameters   (method 5004) 	
	1*,2, 3, 4, 9,
Group A test requirements   (method 5005)	1, 2, 3, 4, 5, 6, 9, 12
Groups C and D end-point   electrical parameters   (method 5005)	1

<sup>\*</sup> PDA applies to subgroup 1.

### 5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

### 6. NOTES

- 6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
- 6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- 6.3 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.

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<u>询"5962-8850501RA"供应商</u>

6.4 Approved source of supply. An approved source of supply is listed herein. Additional sources will be added as they become available. The vendor listed herein has agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

> Military drawing Vendor 1/ similar part **Vendor** part number CAGE number number 037560 5962-8850501RX 51640 AD573SD/883 037568 5962-8850502RX 51640 AD673SD/883

> > Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

**Vendor CAGE** number 51640

**Vendor** name and address

Analog Devices, Incorporated Semiconductor Division 804 Woburn Street Wilmington, MA 01887

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